- Undershoot Protection for Off-Isolation on A and B Ports Up To -2 V
- Bidirectional Data Flow, With Near-Zero Propagation Delay
- Low ON-State Resistance ( $r_{\text {on }}$ ) Characteristics ( $r_{\text {on }}=3 \Omega$ Typical)
- Low Input/Output Capacitance Minimizes Loading and Signal Distortion ( $\mathrm{C}_{\mathrm{io} \text { (OFF) }}=5.5 \mathrm{pF}$ Typical)
- Data and Control Inputs Provide Undershoot Clamp Diodes
- Low Power Consumption (ICC = $3 \mu \mathrm{~A}$ Max)
- $\mathrm{V}_{\mathrm{Cc}}$ Operating Range From 4 V to 5.5 V
- Data I/Os Support 0 to $5-\mathrm{V}$ Signaling Levels (0.8-V, 1.2-V, $1.5-\mathrm{V}, 1.8-\mathrm{V}, 2.5-\mathrm{V}, 3.3-\mathrm{V}, 5-\mathrm{V}$ )
DB, DBQ, DGV, DW, OR PW PACKAGE
(TOP VIEW)


NC - No internal connection

- Control Inputs Can Be Driven by TTL or 5-V/3.3-V CMOS Outputs
- I Ioff Supports Partial-Power-Down Mode Operation
- Latch-Up Performance Exceeds 100 mA Per JESD 78, Class II
- ESD Performance Tested Per JESD 22
- 2000-V Human-Body Model (A114-B, Class II)
- 1000-V Charged-Device Model (C101)
- Supports Both Digital and Analog Applications: USB Interface, Memory Interleaving, Bus Isolation, Low-Distortion Signal Gating


NC - No internal connection

## description/ordering information

The SN74CBT3245C is a high-speed TTL-compatible FET bus switch with low ON-state resistance ( $r_{o n}$ ), allowing for minimal propagation delay. Active Undershoot-Protection Circuitry on the A and B ports of the SN74CBT3245C provides protection for undershoot up to -2 V by sensing an undershoot event and ensuring that the switch remains in the proper OFF state.
The SN74CBT3245C is organized as an 8-bit bus switch with a single output-enable ( $\overline{\mathrm{OE}}$ ) input. When $\overline{\mathrm{OE}}$ is low, the bus switch is ON, and the A port is connected to the B port, allowing bidirectional data flow between ports. When $\overline{O E}$ is high, the bus switch is OFF, and the high-impedance state exists between the $A$ and $B$ ports.

## SN74CBT3245C

## 8-BIT FET BUS SWITCH

## 5-V BUS SWITCH WITH -2-V UNDERSHOOT PROTECTION <br> SCDS131A - SEPTEMBER 2003 - REVISED OCTOBER 2003

## description/ordering information (continued)

This device is fully specified for partial-power-down applications using $l_{\text {off }}$. The $l_{\text {off }}$ feature ensures that damaging current will not backflow through the device when it is powered down. The device has isolation during power off.

To ensure the high-impedance state during power up or power down, $\overline{\mathrm{OE}}$ should be tied to $\mathrm{V}_{\mathrm{CC}}$ through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

ORDERING INFORMATION

| $\mathrm{T}_{\text {A }}$ | PACKAGE $\dagger$ |  | ORDERABLE PART NUMBER | TOP-SIDE MARKING |
| :---: | :---: | :---: | :---: | :---: |
| $-40^{\circ} \mathrm{C}$ to $85^{\circ} \mathrm{C}$ | QFN - RGY | Tape and reel | SN74CBT3245CRGYR | CU245C |
|  | SOIC - DW | Tube | SN74CBT3245CDW | CBT3245C |
|  |  | Tape and reel | SN74CBT3245CDWR |  |
|  | SSOP - DB | Tube | SN74CBT3245CDB | CU245C |
|  |  | Tape and reel | SN74CBT3245CDBR |  |
|  | SSOP (QSOP) - DBQ | Tape and reel | SN74CBT3245CDBQR | CBT3245C |
|  | TSSOP - PW | Tube | SN74CBT3245CPW | CU245C |
|  |  | Tape and reel | SN74CBT3245CPWR |  |
|  | TVSOP - DGV | Tape and reel | SN74CBT3245CDGVR | CU245C |

$\dagger$ Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.

FUNCTION TABLE

| INPUT <br> $\overline{\mathrm{OE}}$ | INPUT/OUTPUT <br> $\mathbf{A}$ | FUNCTION |
| :---: | :---: | :---: |
| L | B | A port = B port |
| H | Z | Disconnect |

## logic diagram (positive logic)



## simplified schematic, each FET switch (SW)


$\dagger$ EN is the internal enable signal applied to the switch.
absolute maximum ratings over operating free-air temperature range (unless otherwise noted) $\ddagger$

$$
\begin{aligned}
& \text { Supply voltage range, } \mathrm{V}_{\mathrm{CC}} \text {......................................................................... }-0.5 \mathrm{~V} \text { to } 7 \mathrm{~V} \\
& \text { Control input voltage range, } \mathrm{V}_{\text {IN }} \text { (see Notes } 1 \text { and 2) .......................................... } 0.5 \mathrm{~V} \text { to } 7 \mathrm{~V} \\
& \text { Switch I/O voltage range, } \mathrm{V}_{\mathrm{I} / \mathrm{O}} \text { (see Notes 1, 2, and 3) ........................................ } 0.5 \mathrm{~V} \text { to } 7 \mathrm{~V}
\end{aligned}
$$

$$
\begin{aligned}
& \text { Package thermal impedance, } \theta_{\mathrm{JA}} \text { (see Note 5): DB package . .................................... } 70^{\circ} \mathrm{C} / \mathrm{W} \\
& \text { (see Note 5): DBQ package . ......................................... . } 68^{\circ} \mathrm{C} / \mathrm{W} \\
& \text { (see Note 5): DGV package . .......................................... } 92^{\circ} \mathrm{C} / \mathrm{W} \\
& \text { (see Note 5): DW package . .......................................... } 58^{\circ} \mathrm{C} / \mathrm{W} \\
& \text { (see Note 5): PW package . .......................................... } 83^{\circ} \mathrm{C} / \mathrm{W} \\
& \text { (see Note 6): RGY package ........................................ } 37^{\circ} \mathrm{C} / \mathrm{W} \\
& \text { Storage temperature range, } \mathrm{T}_{\text {stg }} \\
& \ddagger \text { Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and } \\
& \text { functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not } \\
& \text { implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. } \\
& \text { NOTES: 1. All voltages are with respect to ground unless otherwise specified. } \\
& \text { 2. The input and output voltage ratings may be exceeded if the input and output clamp-current ratings are observed. } \\
& \text { 3. } \mathrm{V}_{\mathrm{I}} \text { and } \mathrm{V}_{\mathrm{O}} \text { are used to denote specific conditions for } \mathrm{V}_{\mathrm{I} / \mathrm{O}} \text {. } \\
& \text { 4. } I_{I} \text { and } \mathrm{I}_{\mathrm{O}} \text { are used to denote specific conditions for } \mathrm{I}_{/} / \mathrm{O} \text {. } \\
& \text { 5. The package thermal impedance is calculated in accordance with JESD 51-7. } \\
& \text { 6. The package thermal impedance is calculated in accordance with JESD 51-5. }
\end{aligned}
$$

recommended operating conditions (see Note 7)

|  |  | MIN | MAX |
| :--- | :--- | ---: | :---: |
| UNIT |  |  |  |
| $\mathrm{V}_{\mathrm{CC}}$ | Supply voltage | 4 | 5.5 |
| $\mathrm{~V}_{\mathrm{IH}}$ | High-level control input voltage | 2 | 5.5 |
| $\mathrm{~V}_{\mathrm{IL}}$ | Low-level control input voltage | 0 | 0.8 |
| $\mathrm{~V}_{\mathrm{I} / \mathrm{O}}$ | Data input/output voltage | 0 | 5.5 |
| $\mathrm{~T}_{\mathrm{A}}$ | Operating free-air temperature | -40 | 85 |

NOTE 7: All unused control inputs of the device must be held at $\mathrm{V}_{\mathrm{CC}}$ or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

## 5-V BUS SWITCH WITH -2-V UNDERSHOOT PROTECTION

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

| PARAMETER |  | TEST CONDITIONS |  |  | MIN | TYP† | MAX | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{V}_{\text {IK }}$ | Control inputs | $\mathrm{V}_{\mathrm{CC}}=4.5 \mathrm{~V}$, | $\mathrm{I}_{\mathrm{N}}=-18 \mathrm{~mA}$ |  |  |  | -1.8 | V |
| VIKU | Data inputs | $\mathrm{V}_{\mathrm{CC}}=5 \mathrm{~V}$, | $0 \mathrm{~mA}>\mathrm{I}_{\mathrm{l}} \geq-50 \mathrm{~mA}$, <br> $\mathrm{V}_{\mathrm{IN}}=\mathrm{V}_{\mathrm{CC}}$ or GND , | Switch OFF |  |  | -2 | V |
| IIN | Control inputs | $\mathrm{V}_{\mathrm{CC}}=5.5 \mathrm{~V}$, | $\mathrm{V}_{\text {IN }}=\mathrm{V}_{\text {CC }}$ or GND |  |  |  | $\pm 1$ | $\mu \mathrm{A}$ |
| $\mathrm{l}^{\text {Oz }}{ }^{\ddagger}$ |  | $\mathrm{V}_{\mathrm{CC}}=5.5 \mathrm{~V}$, | $\begin{aligned} & \mathrm{V}_{\mathrm{O}}=0 \text { to } 5.5 \mathrm{~V}, \\ & \mathrm{~V}_{\mathrm{I}}=0, \end{aligned}$ | Switch OFF, <br> $\mathrm{V}_{\text {IN }}=\mathrm{V}_{\mathrm{CC}}$ or GND |  |  | $\pm 10$ | $\mu \mathrm{A}$ |
| $\mathrm{l}_{\text {off }}$ |  | $V_{C C}=0$, | $\mathrm{V}_{\mathrm{O}}=0$ to 5.5 V , | $\mathrm{V}_{\mathrm{I}}=0$ |  |  | 10 | $\mu \mathrm{A}$ |
| ICC |  | $\mathrm{V}_{\mathrm{CC}}=5.5 \mathrm{~V}$, | $\begin{aligned} & \mathrm{I}_{\mathrm{I} / \mathrm{O}}=0, \\ & \mathrm{~V}_{\mathrm{IN}}=\mathrm{V}_{\mathrm{CC}} \text { or } \mathrm{GND}, \end{aligned}$ | Switch ON or OFF |  |  | 3 | $\mu \mathrm{A}$ |
| $\Delta \mathrm{l}_{\mathrm{CC}}{ }^{\text {§ }}$ | Control inputs | $\mathrm{V}_{\mathrm{CC}}=5.5 \mathrm{~V}$, | One input at 3.4 V, | Other inputs at $\mathrm{V}_{\mathrm{CC}}$ or GND |  |  | 2.5 | mA |
| $\mathrm{C}_{\mathrm{in}}$ | Control inputs | $\mathrm{V}_{\text {IN }}=3 \mathrm{~V}$ or 0 |  |  |  | 4 |  | pF |
| $\mathrm{Cio}_{\mathrm{io}}$ (OFF) |  | $\mathrm{V}_{\mathrm{I} / \mathrm{O}}=3 \mathrm{~V}$ or 0 , | Switch OFF, | $\mathrm{V}_{\text {IN }}=\mathrm{V}_{\text {CC }}$ or GND |  | 5.5 |  | pF |
| Cio (ON) |  | $\mathrm{V}_{\mathrm{I} / \mathrm{O}}=3 \mathrm{~V}$ or 0 , | Switch ON, | $\mathrm{V}_{\text {IN }}=\mathrm{V}_{\text {CC }}$ or GND |  | 14 |  | pF |
| $\mathrm{r}_{\text {on }}{ }^{\text {d }}$ |  | $\begin{aligned} & \mathrm{V} \mathrm{CC}=4 \mathrm{~V}, \\ & \mathrm{TYP} \text { at } \mathrm{V}_{\mathrm{CC}}=4 \mathrm{~V} \end{aligned}$ | $\mathrm{V}_{\mathrm{I}}=2.4 \mathrm{~V}$, | $\mathrm{l}=-15 \mathrm{~mA}$ |  | 8 | 12 | $\Omega$ |
|  |  | $\mathrm{V}_{\mathrm{CC}}=4.5 \mathrm{~V}$ | $\mathrm{V}_{\mathrm{I}}=0$ | $\mathrm{I} \mathrm{O}=64 \mathrm{~mA}$ |  | 3 | 6 |  |
|  |  | $10=30 \mathrm{~mA}$ |  |  | 3 | 6 |  |
|  |  | $\mathrm{V}_{\mathrm{I}}=2.4 \mathrm{~V}$, | $\mathrm{l} \mathrm{O}=-15 \mathrm{~mA}$ |  | 5 | 10 |  |

$\mathrm{V}_{\mathrm{IN}}$ and $\mathrm{I}_{\mathrm{IN}}$ refer to control inputs. $\mathrm{V}_{\mathrm{I}}, \mathrm{V}_{\mathrm{O}}, \mathrm{I}_{\mathrm{I}}$, and $\mathrm{I}_{\mathrm{O}}$ refer to data pins.
$\dagger$ All typical values are at $\mathrm{V}_{\mathrm{CC}}=5 \mathrm{~V}$ (unless otherwise noted), $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$.
$\ddagger$ For I/O ports, the parameter IOZ includes the input leakage current.
§ This is the increase in supply current for each input that is at the specified voltage level, rather than $V_{C C}$ or GND.
II Measured by the voltage drop between the $A$ and $B$ terminals at the indicated current through the switch. ON-state resistance is determined by the lower of the voltages of the two ( A or B ) terminals.
switching characteristics over recommended operating free-air temperature range (unless otherwise noted) (see Figure 3)

| PARAMETER | FROM (INPUT) | TO (OUTPUT) | $\mathrm{V}_{\mathrm{CC}}=4 \mathrm{~V}$ | $\begin{gathered} \mathrm{VCC}=5 \mathrm{~V} \\ \pm 0.5 \mathrm{~V} \end{gathered}$ |  | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | MIN MAX | MIN | MAX |  |
| $t_{\text {pd }}{ }^{\text {\# }}$ | A or B | B or A | 0.24 |  | 0.15 | ns |
| ten | $\overline{\mathrm{OE}}$ | A or B | 5.1 | 1.5 | 4.7 | ns |
| $\mathrm{t}_{\text {dis }}$ | $\overline{\mathrm{OE}}$ | A or B | 4.9 | 1.5 | 5.3 | ns |

\# The propagation delay is the calculated RC time constant of the typical ON-state resistance of the switch and the specified load capacitance, when driven by an ideal voltage source (zero output impedance).
undershoot characteristics (see Figures 1 and 2)

| PARAMETER | TEST CONDITIONS |  |  | MIN | TYP† | MAX | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| V OUTU | $\mathrm{V}_{\mathrm{CC}}=5.5 \mathrm{~V}$, | Switch OFF, | $\mathrm{V}_{\text {IN }}=\mathrm{V}_{\text {CC }}$ or GND | 2 | $\mathrm{V}_{\mathrm{OH}}-0.3$ |  | V |

$\dagger$ All typical values are at $\mathrm{V}_{\mathrm{CC}}=5 \mathrm{~V}$ (unless otherwise noted), $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$.


Figure 1. Device Test Setup


Figure 2. Transient Input Voltage $\left(\mathrm{V}_{\mathrm{I}}\right)$ and Output Voltage (VOUTU) Waveforms (Switch OFF)

## PARAMETER MEASUREMENT INFORMATION



| TEST | $\mathrm{V}_{\text {cc }}$ | S1 | $\mathrm{R}_{\mathrm{L}}$ | $V_{1}$ | $\mathrm{C}_{\mathrm{L}}$ | $\mathrm{V}_{\Delta}$ |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| ${ }^{\text {tpd}}$ (s) | $\begin{gathered} 5 \mathrm{~V} \pm 0.5 \mathrm{~V} \\ 4 \mathrm{~V} \end{gathered}$ | Open Open | $\begin{aligned} & 500 \Omega \\ & 500 \Omega \end{aligned}$ | $V_{C C}$ or GND <br> $V_{C C}$ or GND | $\begin{aligned} & 50 \mathrm{pF} \\ & 50 \mathrm{pF} \end{aligned}$ |  |
| tPLZ/tPZL | $\begin{gathered} 5 \mathrm{~V} \pm 0.5 \mathrm{~V} \\ 4 \mathrm{~V} \end{gathered}$ | $\begin{aligned} & 7 \mathrm{~V} \\ & 7 \mathrm{~V} \end{aligned}$ | $\begin{aligned} & 500 \Omega \\ & 500 \Omega \end{aligned}$ | GND GND | $\begin{aligned} & 50 \mathrm{pF} \\ & 50 \mathrm{pF} \end{aligned}$ | $\begin{aligned} & 0.3 \mathrm{~V} \\ & 0.3 \mathrm{~V} \end{aligned}$ |
| tPHZ/tPZH | $\begin{gathered} 5 \mathrm{~V} \pm 0.5 \mathrm{~V} \\ 4 \mathrm{~V} \end{gathered}$ | Open Open | $\begin{aligned} & 500 \Omega \\ & 500 \Omega \end{aligned}$ | $\begin{aligned} & \mathrm{v}_{\mathrm{CC}} \\ & \mathrm{v}_{\mathrm{CC}} \end{aligned}$ | $\begin{aligned} & 50 \mathrm{pF} \\ & 50 \mathrm{pF} \end{aligned}$ | $\begin{aligned} & 0.3 \mathrm{~V} \\ & 0.3 \mathrm{~V} \end{aligned}$ |



NOTES: A. $C_{L}$ includes probe and jig capacitance.
B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control.

Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
C. All input pulses are supplied by generators having the following characteristics: $\mathrm{PRR} \leq 10 \mathrm{MHz}, \mathrm{Z}_{\mathrm{O}}=50 \Omega, \mathrm{t}_{\mathrm{r}} \leq 2.5 \mathrm{~ns}, \mathrm{t}_{\mathrm{f}} \leq 2.5 \mathrm{~ns}$.
D. The outputs are measured one at a time with one transition per measurement.
E. $\quad t_{P L Z}$ and $t_{P H Z}$ are the same as $t_{\text {dis }}$.
F. tpZL and tPZH are the same as ten.
G. $t_{P L H}$ and $t_{P H L}$ are the same as $t_{p d(s) . ~ T h e ~ t p d ~ p r o p a g a t i o n ~ d e l a y ~ i s ~ t h e ~ c a l c u l a t e d ~ R C ~ t i m e ~ c o n s t a n t ~ o f ~ t h e ~ t y p i c a l ~ O N-s t a t e ~}^{\text {a }}$ resistance of the switch and the specified load capacitance, when driven by an ideal voltage source (zero output impedance).
H. All parameters and waveforms are not applicable to all devices.

Figure 3. Test Circuit and Voltage Waveforms

## PACKAGING INFORMATION

| Orderable Device | Status ${ }^{(1)}$ | Package Type | Package Drawing | Pins | Package Qty | $\text { Eco Plan }{ }^{(2)}$ | Lead/Ball Finish | MSL Peak Temp ${ }^{(3)}$ |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| SN74CBT3245CDBQR | ACTIVE | $\begin{aligned} & \hline \text { SSOP/ } \\ & \text { QSOP } \end{aligned}$ | DBQ | 20 | 2500 | $\begin{gathered} \text { Green (RoHS \& } \\ \text { no Sb/Br) } \end{gathered}$ | CU NIPDAU | Level-2-260C-1YEAR |
| SN74CBT3245CDBQRE4 | ACTIVE | $\begin{aligned} & \text { SSOP/ } \\ & \text { QSOP } \end{aligned}$ | DBQ | 20 | 2500 | $\begin{gathered} \text { Green (RoHS \& } \\ \text { no } \mathrm{Sb} / \mathrm{Br} \text { ) } \end{gathered}$ | CU NIPDAU | Level-2-260C-1YEAR |
| SN74CBT3245CDBR | ACTIVE | SSOP | DB | 20 | 2000 | $\begin{gathered} \text { Green (RoHS \& } \\ \text { no } \mathrm{Sb} / \mathrm{Br} \text { ) } \end{gathered}$ | CU NIPDAU | Level-1-260C-UNLIM |
| SN74CBT3245CDBRE4 | ACTIVE | SSOP | DB | 20 | 2000 | $\begin{gathered} \hline \text { Green (RoHS \& } \\ \text { no } \mathrm{Sb} / \mathrm{Br} \text { ) } \\ \hline \end{gathered}$ | CU NIPDAU | Level-1-260C-UNLIM |
| SN74CBT3245CDGVR | ACTIVE | TVSOP | DGV | 20 | 2000 | $\begin{gathered} \text { Green (RoHS \& } \\ \text { no } \mathrm{Sb} / \mathrm{Br}) \end{gathered}$ | CU NIPDAU | Level-1-260C-UNLIM |
| SN74CBT3245CDGVRE4 | ACtive | TVSOP | DGV | 20 | 2000 | Green (RoHS \& no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |
| SN74CBT3245CDW | ACTIVE | SOIC | DW | 20 | 25 | $\begin{gathered} \hline \text { Green (RoHS \& } \\ \text { no } \mathrm{Sb} / \mathrm{Br} \text { ) } \\ \hline \end{gathered}$ | CU NIPDAU | Level-1-260C-UNLIM |
| SN74CBT3245CDWE4 | ACTIVE | SOIC | DW | 20 | 25 | Green (RoHS \& no $\mathrm{Sb} / \mathrm{Br})$ | CU NIPDAU | Level-1-260C-UNLIM |
| SN74CBT3245CDWR | ACTIVE | SOIC | DW | 20 | 2000 | $\begin{gathered} \text { Green (RoHS \& } \\ \text { no } \mathrm{Sb} / \mathrm{Br} \text { ) } \end{gathered}$ | CU NIPDAU | Level-1-260C-UNLIM |
| SN74CBT3245CDWRE4 | ACTIVE | SOIC | DW | 20 | 2000 | $\begin{gathered} \text { Green (RoHS \& } \\ \text { no } \mathrm{Sb} / \mathrm{Br} \text { ) } \\ \hline \end{gathered}$ | CU NIPDAU | Level-1-260C-UNLIM |
| SN74CBT3245CPW | ACTIVE | TSSOP | PW | 20 | 70 | $\begin{gathered} \hline \text { Green (RoHS \& } \\ \text { no } \mathrm{Sb} / \mathrm{Br}) \\ \hline \end{gathered}$ | CU NIPDAU | Level-1-260C-UNLIM |
| SN74CBT3245CPWE4 | ACTIVE | TSSOP | PW | 20 | 70 | $\begin{gathered} \hline \text { Green (RoHS \& } \\ \text { no } \mathrm{Sb} / \mathrm{Br}) \end{gathered}$ | CU NIPDAU | Level-1-260C-UNLIM |
| SN74CBT3245CPWR | ACTIVE | TSSOP | PW | 20 | 2000 | Green (RoHS \& no $\mathrm{Sb} / \mathrm{Br}$ ) | CU NIPDAU | Level-1-260C-UNLIM |
| SN74CBT3245CPWRE4 | ACTIVE | TSSOP | PW | 20 | 2000 | $\begin{gathered} \text { Green (RoHS \& } \\ \text { no } \mathrm{Sb} / \mathrm{Br} \text { ) } \end{gathered}$ | CU NIPDAU | Level-1-260C-UNLIM |
| SN74CBT3245CRGYR | ACTIVE | QFN | RGY | 20 | 1000 | $\begin{gathered} \text { Green (RoHS \& } \\ \text { no } \mathrm{Sb} / \mathrm{Br} \text { ) } \end{gathered}$ | CU NIPDAU | Level-2-260C-1YEAR |

${ }^{(1)}$ The marketing status values are defined as follows:
ACTIVE: Product device recommended for new designs.
LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.
NRND: Not recommended for new designs. Device is in production to support existing customers, but Tl does not recommend using this part in a new design.
PREVIEW: Device has been announced but is not in production. Samples may or may not be available.
OBSOLETE: TI has discontinued the production of the device.
${ }^{(2)}$ Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS) or Green (RoHS \& no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.
TBD: The $\mathrm{Pb}-\mathrm{Free} / \mathrm{Green}$ conversion plan has not been defined.
Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed $0.1 \%$ by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb -Free products are suitable for use in specified lead-free processes.
Green (RoHS \& no $\mathbf{S b} / \mathrm{Br}$ ): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine ( Br ) and Antimony ( Sb ) based flame retardants ( Br or Sb do not exceed $0.1 \%$ by weight in homogeneous material)
${ }^{(3)}$ MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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| PIM ** | $\mathbf{1 4}$ | $\mathbf{1 6}$ | $\mathbf{2 0}$ | $\mathbf{2 4}$ | $\mathbf{3 8}$ | $\mathbf{4 8}$ | $\mathbf{5 6}$ |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| A MAX | 3,70 | 3,70 | 5,10 | 5,10 | 7,90 | 9,80 | 11,40 |
| A MIN | 3,50 | 3,50 | 4,90 | 4,90 | 7,70 | 9,60 | 11,20 |

NOTES: A. All linear dimensions are in millimeters.
B. This drawing is subject to change without notice.
C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15 per side.
D. Falls within JEDEC: $24 / 48$ Pins - MO-153

14/16/20/56 Pins - MO-194

DW (R-PDSO-G2O)

## PLASTIC SMALL-OUTLINE PACKAGE



NOTES: A. All linear dimensions are in inches (millimeters).
B. This drawing is subject to change without notice.
C. Body dimensions do not include mold flash or protrusion not to exceed $0.006(0,15)$.
D. Falls within JEDEC MS-013 variation AC.

DBQ (R-PDSO-G20)

## PLASTIC SMALL-OUTLINE PACKAGE



NOTES: A. All linear dimensions are in inches (millimeters).
B. This drawing is subject to change without notice.
C. Body dimensions do not include mold flash or protrusion not to exceed $0.006(0,15)$ per side.
D. Falls within JEDEC MO-137 variation AD.


NOTES: A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.
B. This drawing is subject to change without notice.
C. QFN (Quad Flatpack No-Lead) package configuration.

The package thermal pad must be soldered to the board for thermal and mechanical performance
Pin 1 identifiers are located on both top and bottom of the package and within the zone indicated. The Pin 1 identifiers are either a molded, marked, or metal feature.
F. Package complies to JEDEC MO-241 variation BC.


| DIM PINS ** | $\mathbf{1 4}$ | $\mathbf{1 6}$ | $\mathbf{2 0}$ | $\mathbf{2 4}$ | $\mathbf{2 8}$ | $\mathbf{3 0}$ | $\mathbf{3 8}$ |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| A MAX | 6,50 | 6,50 | 7,50 | 8,50 | 10,50 | 10,50 | 12,90 |
| A MIN | 5,90 | 5,90 | 6,90 | 7,90 | 9,90 | 9,90 | 12,30 |

NOTES: A. All linear dimensions are in millimeters.
B. This drawing is subject to change without notice.
C. Body dimensions do not include mold flash or protrusion not to exceed 0,15.
D. Falls within JEDEC MO-150


| PIMS $^{* *}$ | $\mathbf{8}$ | $\mathbf{1 4}$ | $\mathbf{1 6}$ | $\mathbf{2 0}$ | $\mathbf{2 4}$ | $\mathbf{2 8}$ |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| A MAX | 3,10 | 5,10 | 5,10 | 6,60 | 7,90 | 9,80 |
| A MIN | 2,90 | 4,90 | 4,90 | 6,40 | 7,70 | 9,60 |

NOTES: A. All linear dimensions are in millimeters.
B. This drawing is subject to change without notice.
C. Body dimensions do not include mold flash or protrusion not to exceed 0,15 .
D. Falls within JEDEC MO-153

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